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| Notice of References Cited | Application/Control No. 10/635,667 | Applicant(s)/Patent Under Reexamination HAYASHI, YUKA | |
| | Examiner Lana N. Le | Art Unit 2685 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-2005/0085263 | 04-2005 | Kim et al. | 455/556.1 |
| * | B | US-6,317,609 | 11-2001 | Alperovich et al. | 455/556.1 |
| * | C | US-6,915,119 | 07-2005 | Konishi, Masahiro | 455/566 |
| * | D | US-6,538,698 | 03-2003 | Anderson, Eric C. | 348/333.05 |
| * | E | US-6,122,521 | 09-2000 | Wilkinson et al. | 455/457 |
| * | F | US-2004/0204063 | 10-2004 | Van Erlach, Julian | 455/556.1 |
| * | G | US-5,926,218 | 07-1999 | Smith, Stephen P. | 348/333.11 |
| * | H | US-6,522,889 | 02-2003 | Aarnio, Ari | 455/457 |
| * | I | US-6,694,133 | 02-2004 | Tobita et al. | 455/566 |
| * | J | US-2005/0140792 | 06-2005 | Hermesen, Markus | 348/231.2 |
| * | K | US-6,795,715 | 09-2004 | Kubo et al. | 455/90.1 |
| * | L | US-5,155,774 | 10-1992 | Numagami, Hideo | 348/333.05 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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